

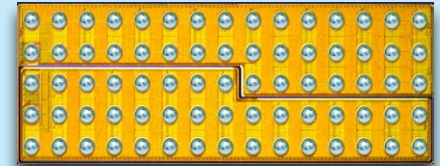
EPC2103 – Enhancement-Mode GaN Power Transistor Half-Bridge

 $V_{DS}, 80\text{ V}$
 $R_{DS(on)}, 5.5\text{ m}\Omega$
 $I_D, 30\text{ A}$


Revised June 19, 2020

Gallium Nitride's exceptionally high electron mobility and low temperature coefficient allows very low $R_{DS(on)}$, while its lateral device structure and majority carrier diode provide exceptionally low Q_G and zero Q_{RR} . The end result is a device that can handle tasks where very high switching frequency, and low on-time are beneficial as well as those where on-state losses dominate.

Questions:
Ask a GaN
Expert



Die Size: 6.05 x 2.3 mm

EPC2103 eGaN® ICs are supplied only in passivated die form with solder bumps.

Applications

- High frequency DC-DC
- Motor drive

Benefits

- Ultra high efficiency
- High frequency operation
- High density footprint

Maximum Ratings				
DEVICE	PARAMETER		VALUE	UNIT
Q1 & Q2	V_{DS}	Drain-to-Source Voltage (Continuous)	80	V
		Drain-to-Source Voltage (up to 10,000 5 ms pulses at 150°C)	96	
	I_D	Continuous ($T_A = 25^\circ\text{C}$, $R_{\theta JA} = 13^\circ\text{C/W}$)	30	A
		Pulsed (25°C , $T_{PULSE} = 300\ \mu\text{s}$)	195	
	V_{GS}	Gate-to-Source Voltage	6	V
		Gate-to-Source Voltage	-4	
T_J	Operating Temperature	-40 to 150	°C	
T_{STG}	Storage Temperature	-40 to 150		

Thermal Characteristics			
PARAMETER		TYP	UNIT
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	0.3	°C/W
$R_{\theta JB}$	Thermal Resistance, Junction-to-Board	2.2	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1)	42	

Note 1: $R_{\theta JA}$ is determined with the device mounted on one square inch of copper pad, single layer 2 oz copper on FR4 board. See https://epc-co.com/epc/documents/product-training/Appnote_Thermal_Performance_of_eGaN_FETs.pdf for details

Static Characteristics ($T_J = 25^\circ\text{C}$ unless otherwise stated)								
DEVICE	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT	
Q1 & Q2	BV_{DSS}	Drain-to-Source Voltage	$V_{GS} = 0\text{ V}$, $I_D = 0.5\text{ mA}$	80			V	
	I_{DSS}	Drain-Source Leakage	$V_{DS} = 64\text{ V}$, $V_{GS} = 0\text{ V}$	0.007	0.4		mA	
	I_{GSS}	Gate-to-Source Forward Leakage [#]	$V_{GS} = 5\text{ V}$		0.013	6.5		mA
		Gate-to-Source Reverse Leakage	$V_{GS} = -4\text{ V}$		0.007	0.4		mA
	$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 7\text{ mA}$	0.8	1.3	2.5		V
	$R_{DS(on)}$	Drain-Source On Resistance	$V_{GS} = 5\text{ V}$, $I_D = 20\text{ A}$		4	5.5		mΩ
	V_{SD}	Source-Drain Forward Voltage [#]	$I_S = 0.5\text{ A}$, $V_{GS} = 0\text{ V}$		1.8			V

[#] Defined by design. Not subject to production test.

Scan QR code or click link below for more information including reliability reports, device models, demo boards!



<https://l.ead.me/EPC2103>

Dynamic Characteristics[#] (T_j = 25°C unless otherwise stated)

DEVICE	PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
Q1	C _{ISS}	Input Capacitance	V _{DS} = 40 V, V _{GS} = 0 V		730	880	pF
	C _{RSS}	Reverse Transfer Capacitance			7		
	C _{OSS}	Output Capacitance			445	670	
	C _{OSS(ER)}	Effective Output Capacitance, Energy Related (Note 2)	V _{DS} = 0 to 40 V, V _{GS} = 0 V		573		
	C _{OSS(TR)}	Effective Output Capacitance, Time Related (Note 3)			733		
	Q _G	Total Gate Charge	V _{DS} = 40 V, V _{GS} = 5 V, I _D = 20 A		6.5	8	nC
	Q _{GS}	Gate-to-Source Charge	V _{DS} = 40 V, I _D = 20 A		2.2		
	Q _{GD}	Gate-to-Drain Charge			1.1		
	Q _{G(TH)}	Gate Charge at Threshold			1.5		
	Q _{OSS}	Output Charge	V _{DS} = 40 V, V _{GS} = 0 V		30	45	
	Q _{RR}	Source-Drain Recovery Charge			0		
Q2	C _{ISS}	Input Capacitance	V _{DS} = 40 V, V _{GS} = 0 V		730	880	pF
	C _{RSS}	Reverse Transfer Capacitance			7		
	C _{OSS}	Output Capacitance			525	790	
	C _{OSS(ER)}	Effective Output Capacitance, Energy Related (Note 2)	V _{DS} = 0 to 40 V, V _{GS} = 0 V		668		
	C _{OSS(TR)}	Effective Output Capacitance, Time Related (Note 3)			855		
	Q _G	Total Gate Charge	V _{DS} = 40 V, V _{GS} = 5 V, I _D = 20 A		6.5	8	nC
	Q _{GS}	Gate-to-Source Charge	V _{DS} = 40 V, I _D = 20 A		2.2		
	Q _{GD}	Gate-to-Drain Charge			1.1		
	Q _{G(TH)}	Gate Charge at Threshold			1.5		
	Q _{OSS}	Output Charge	V _{DS} = 40 V, V _{GS} = 0 V		34	51	
	Q _{RR}	Source-Drain Recovery Charge			0		

[#] Defined by design. Not subject to production test.

All measurements were done with substrate connected to source.

Note 2: C_{OSS(ER)} is a fixed capacitance that gives the same stored energy as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS}.

Note 3: C_{OSS(TR)} is a fixed capacitance that gives the same charging time as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS}.

Figure 1 (Q1 & Q2): Typical Output Characteristics at 25°C

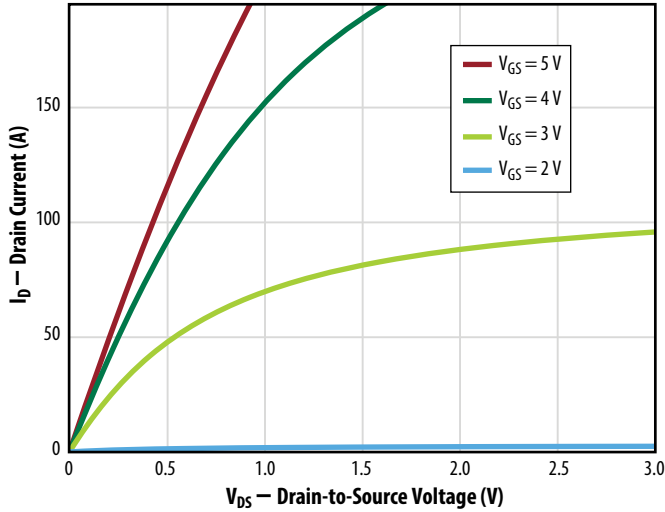


Figure 2 (Q1 & Q2): Typical Transfer Characteristics

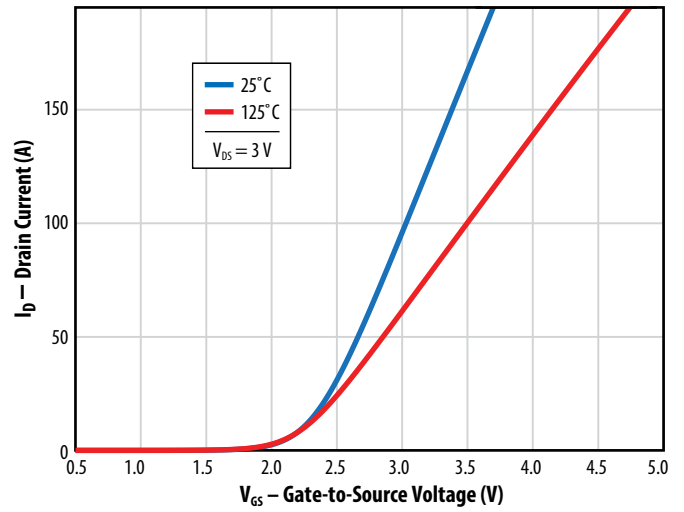


Figure 3 (Q1 & Q2): Typical $R_{DS(on)}$ vs. V_{GS} for Various Drain Currents

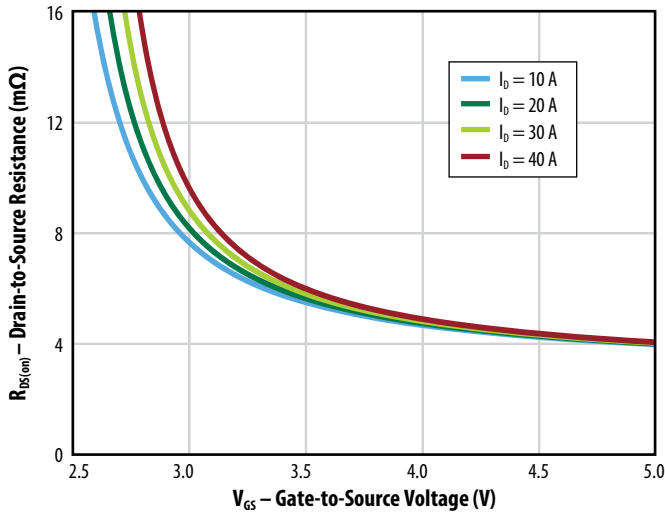


Figure 4 (Q1 & Q2): Typical $R_{DS(on)}$ vs. V_{GS} for Various Temps.

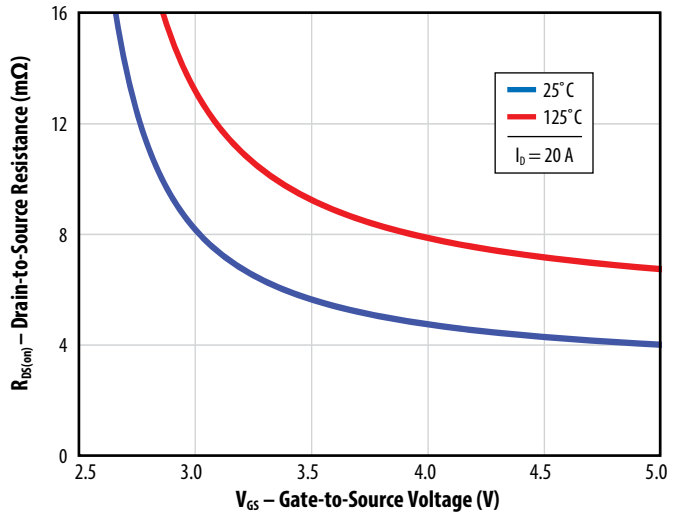


Figure 5a (Q1): Typical Capacitance (Linear Scale)

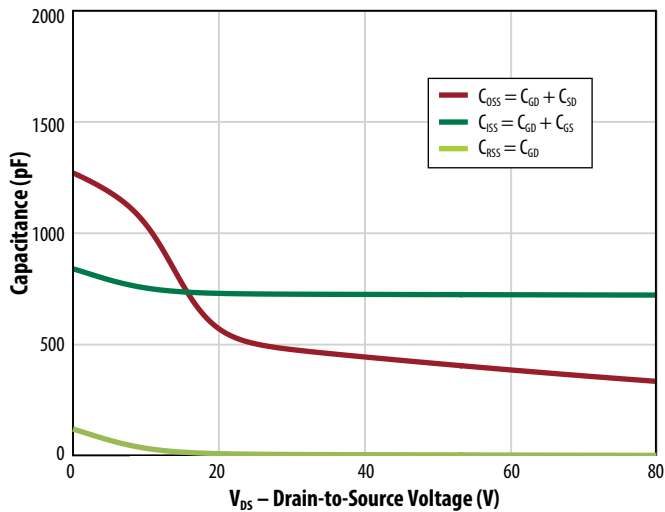


Figure 5b (Q1): Typical Capacitance (Log Scale)

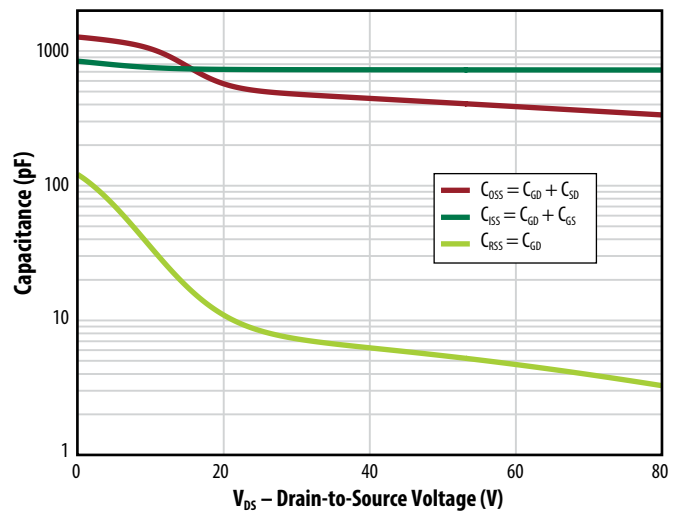


Figure 5c (Q2): Typical Capacitance (Linear Scale)

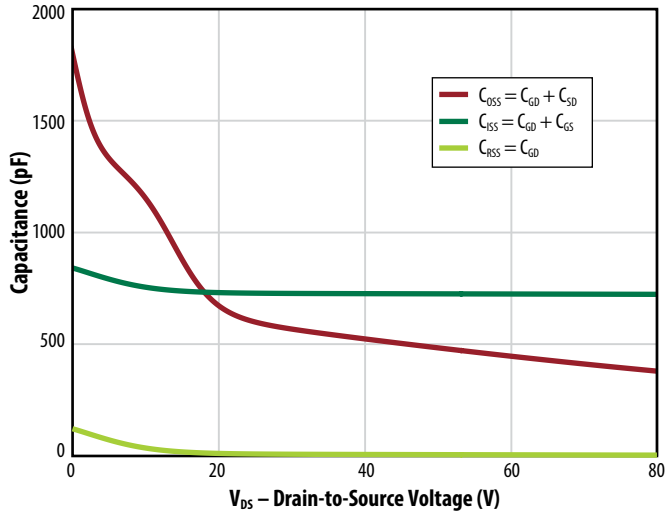


Figure 5d (Q2): Typical Capacitance (Log Scale)

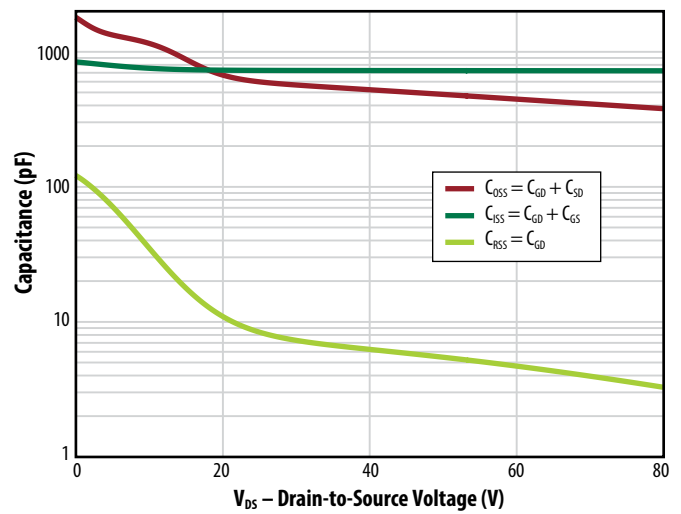


Figure 6a (Q1): Typical Output Charge and C_{oss} Stored Energy

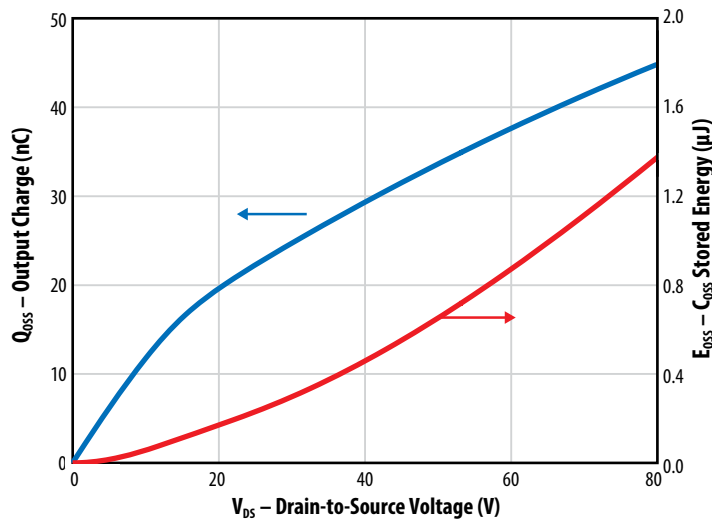


Figure 6b (Q2): Typical Output Charge and C_{oss} Stored Energy

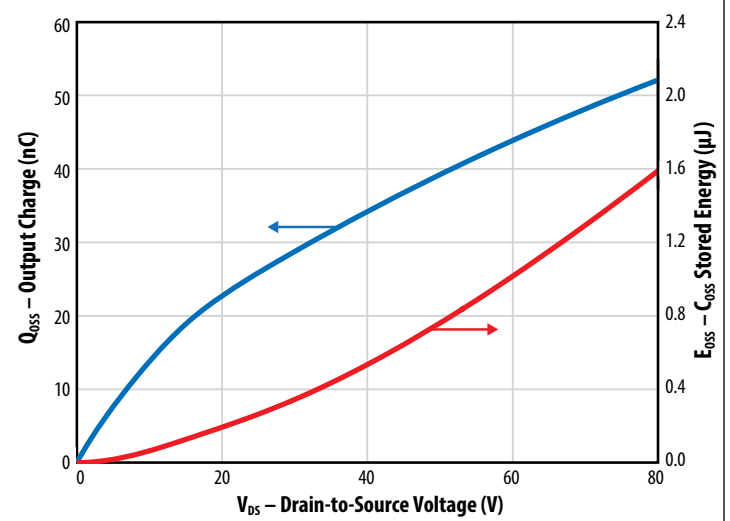


Figure 7 (Q1 & Q2): Typical Gate Charge

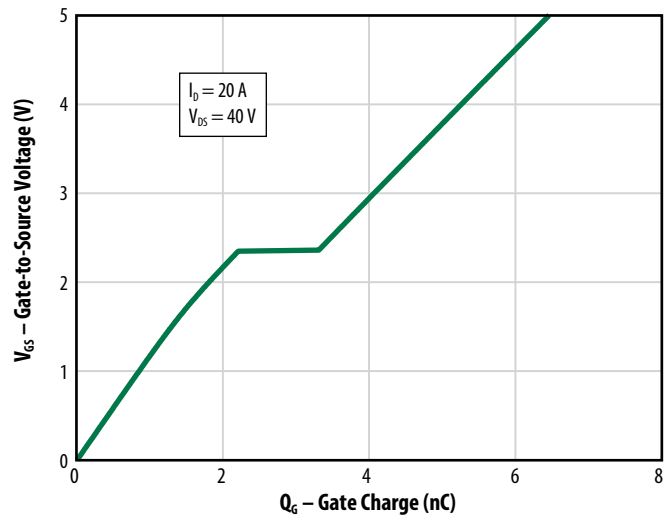
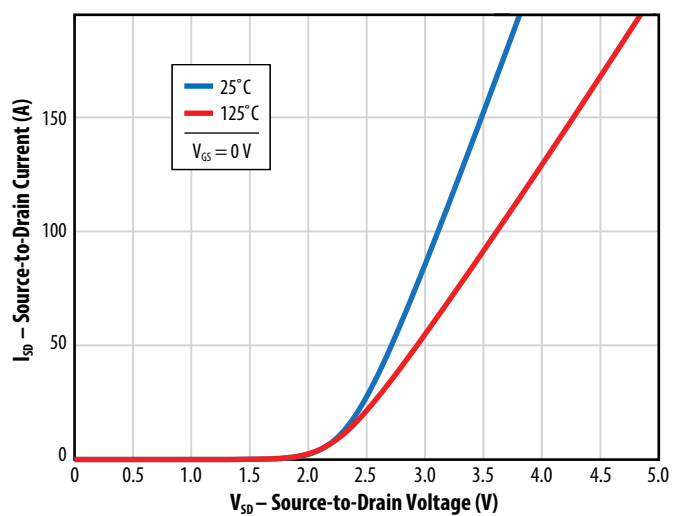


Figure 8 (Q1 & Q2): Typical Reverse Drain-Source Characteristics



Note: Negative gate drive voltage increases the reverse drain-source voltage. EPC recommends 0V for OFF.

Figure 9 (Q1 & Q2):
Typical Normalized On-State Resistance vs. Temperature

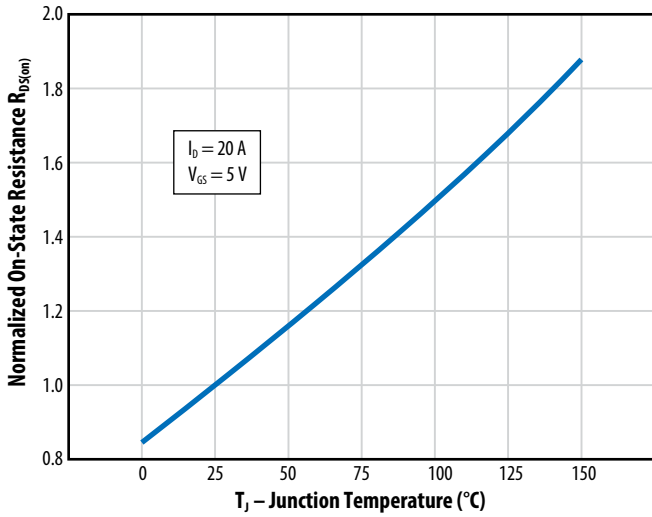


Figure 10 (Q1 & Q2):
Typical Normalized Threshold Voltage vs. Temperature

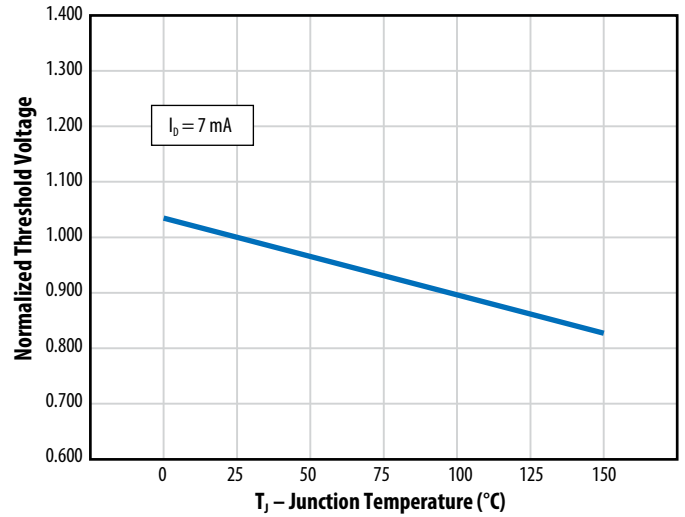


Figure 11a
Typical Transient Thermal Response Curves

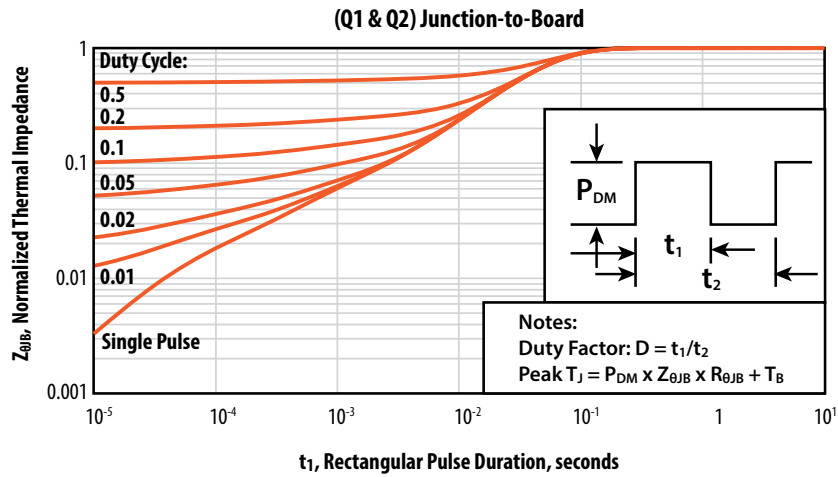


Figure 11b
Typical Transient Thermal Response Curves

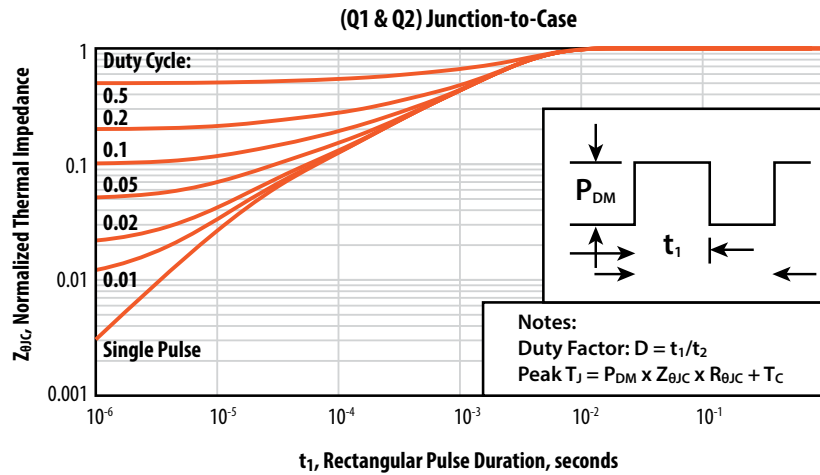


Figure 12 (Q1 & Q2): Safe Operating Area

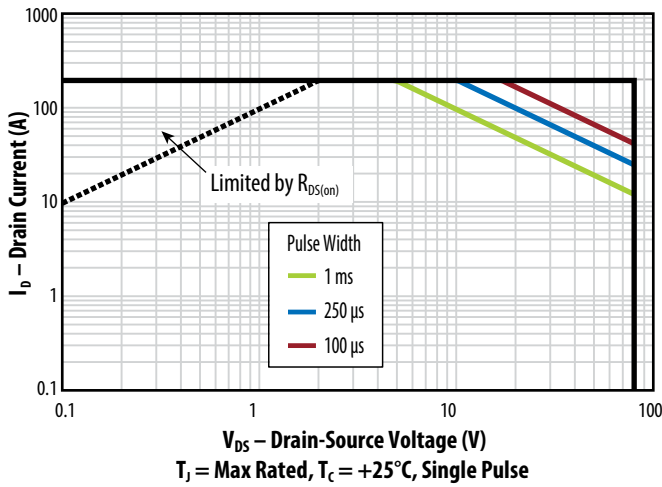
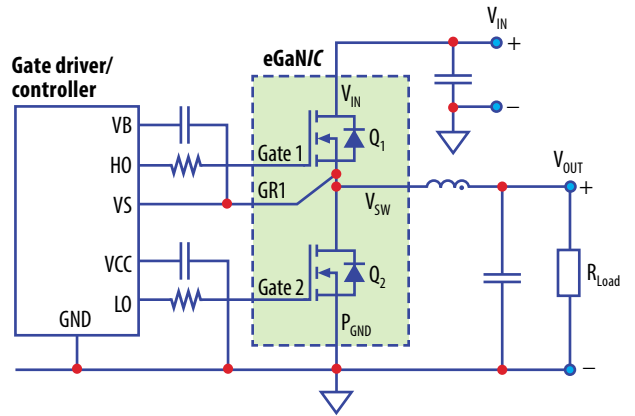
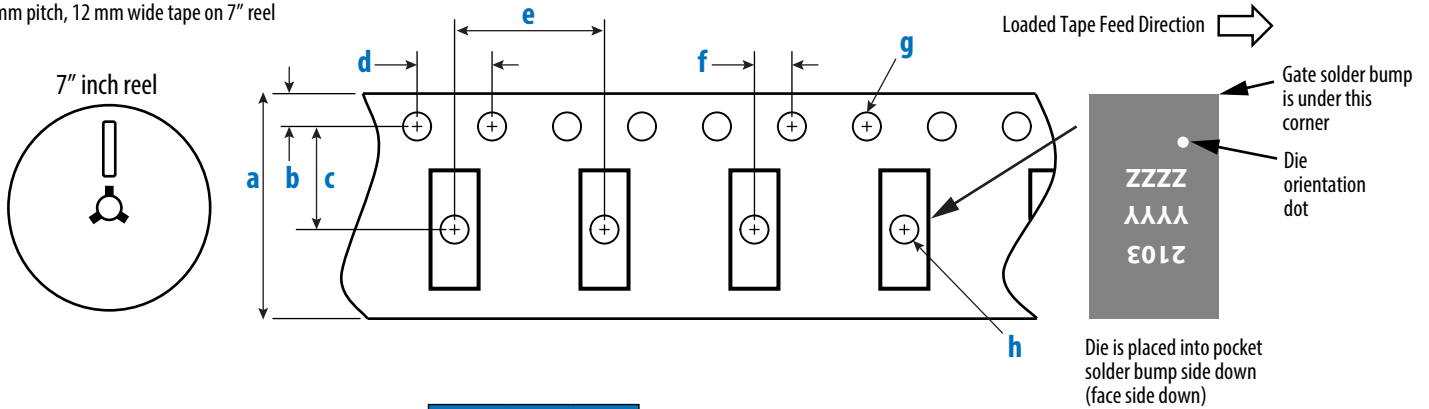


Figure 13: Application Circuit



TAPE AND REEL CONFIGURATION

8 mm pitch, 12 mm wide tape on 7" reel

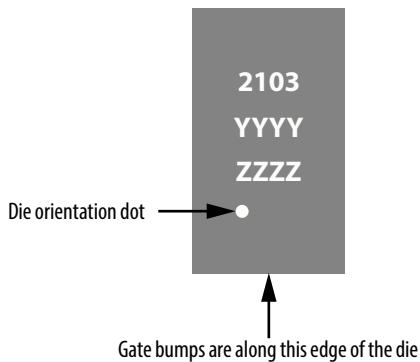


EPC2103 (Note 1)	Dimension (mm)		
	Target	MIN	MAX
a	12.00	11.90	12.30
b	1.75	1.65	1.85
c (Note 2)	5.50	5.45	5.55
d	4.00	3.90	4.10
e	8.00	7.90	8.10
f (Note 2)	2.00	1.95	2.05
g	1.50	1.50	1.60
h	1.50	1.50	1.75

Note 1: MSL 1 (moisture sensitivity level 1) classified according to IPC/ JEDEC industry standard.

Note 2: Pocket position is relative to the sprocket hole measured as true position of the pocket, not the pocket hole.

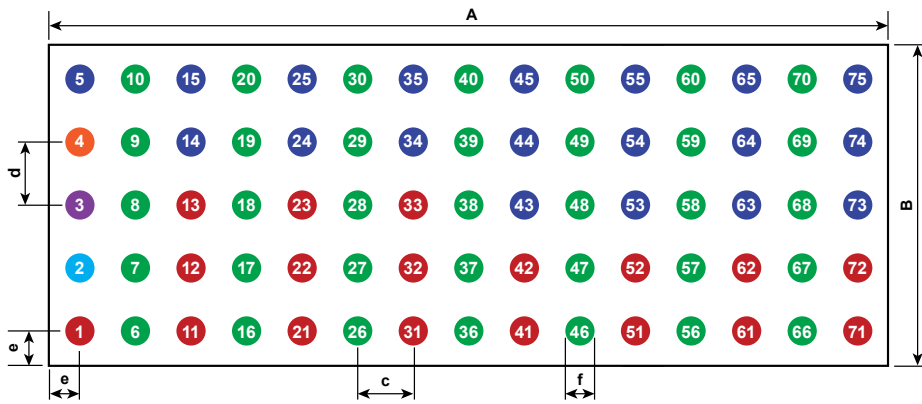
DIE MARKINGS



Part Number	Laser Markings		
	Part # Marking Line 1	Lot_Date Code Marking Line 2	Lot_Date Code Marking Line 3
EPC2103	2103	YYYY	ZZZZ

DIE OUTLINE

Solder Bump View



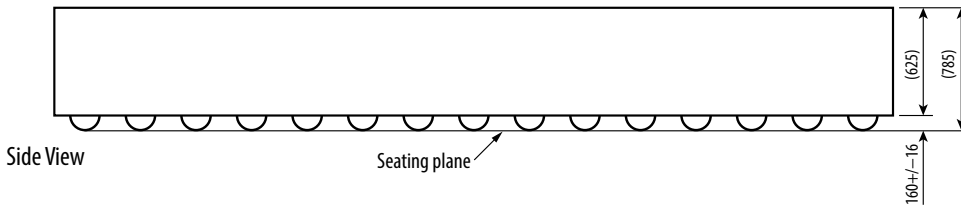
DIM	MIN	Nominal	MAX
A	6020	6050	6080
B	2270	2300	2330
c	400	400	400
d	450	450	450
e	210	225	240
f	187	208	229

Pad 2 is Gate 1 (high side); Pad 3 is HS Gate Return; Pad 4 is G2;

Pads 1, 11, 12, 13, 21, 22, 23, 31, 32, 33, 41, 42, 51, 52, 61, 62, 71, 72 are V_{IN} ;

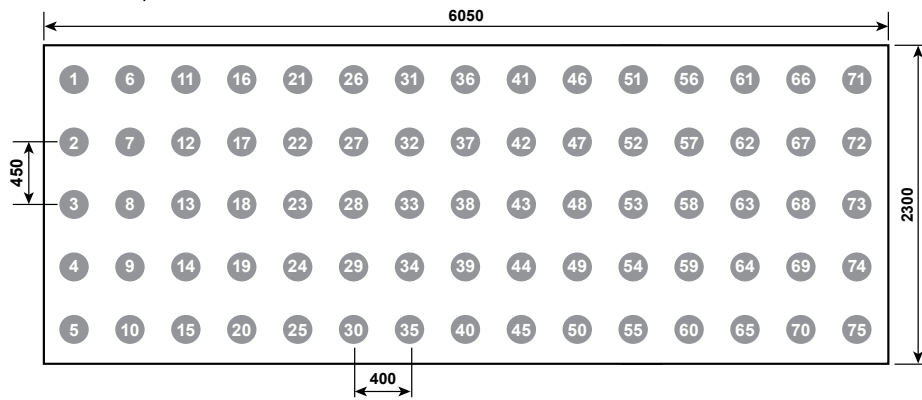
Pads 5, 14, 15, 24, 25, 34, 35, 43, 44, 45, 53, 54, 55, 63, 64, 65, 73, 74, 75 Ground;

Pads 6, 7, 8, 9, 10, 16, 17, 18, 19, 20, 26, 27, 28, 29, 30, 36, 37, 38, 39, 40, 46, 47, 48, 49, 50, 56, 57, 58, 59, 60, 66, 67, 68, 69, 70 are Switch Node



RECOMMENDED LAND PATTERN

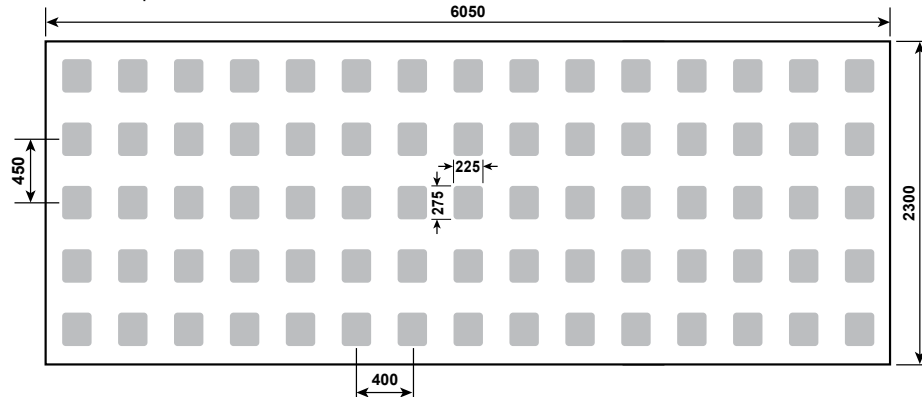
(measurements in μm)



The land pattern is solder mask defined.

RECOMMENDED STENCIL DRAWING

(measurements in μm)



Recommended stencil should be 4 mil (100 μm) thick, must be laser cut, openings per drawing.

Intended for use with SAC305 Type 4 solder, reference 88.5% metals content.

Additional assembly resources available at: <https://epc-co.com/epc/design-support>

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